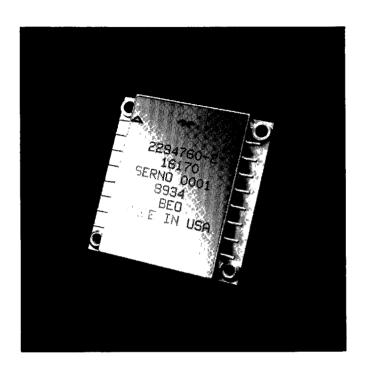
TELEDYNE MICROELECTRONICS



Power Hybrid, Full Bridge P/N 2294760

DESCRIPTION

The 2294760 Power Hybrid contains four N-Channel Enhancement mode high voltage power MOSFETS. Each is coupled with a blocking Schottky diode on the drain and a by-pass ultrafast recovery diode from the source to eliminate momentary shoot-through conditions caused by induced slow MOSFET recovery. Each MOSFET gate is also connected to back-to-back zeners for gate overvoltage protection.

The components are housed in hermetically sealed 16-pin packages. The hybrid is specified for operation over the temperature range of $-55\,^{\circ}\text{C}$ to $125\,^{\circ}\text{C}$ and is designed for high reliability power switching applications.

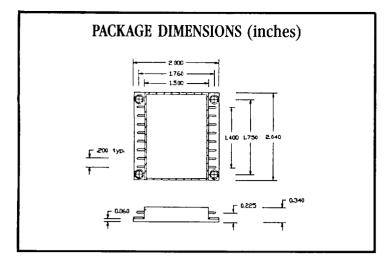
Modular thermally managed power packaging designs, certification to MIL-H-38534 and screening to MIL-STD-883 Method 5008, make this hybrid an excellent choice for Military, Avionic (Class ''H'') and Space (Class ''K'') applications.

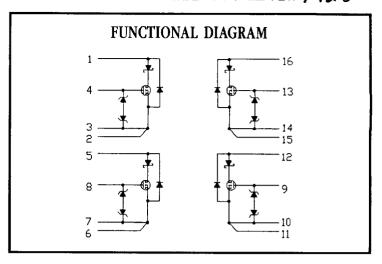
FEATURES

- Isolated metal hermetic power case
- Low thermal resistance: 0.3 °C/W max
- 25A/500V rating
- High frequency switching
- Certification to MIL-H-38534
- Screening to MIL-STD-883
- Other circuit configurations, component types, voltage ratings, etc., are also available.

APPLICATIONS

- PWM and Resonant Mode Power Supply
- Motor Drives
- Inverters





ABSOLUTE MAXIMUM RATINGS (Tc = 25°C unless otherwise noted) P/N 2294760

VDSS	Drain to Source Voltage (MOSFET and By-pass diode)
I_D	Drain Current
i	Continuous (MOSFET and Schottky)25A
	Pulsed [©] (MOSFET and Schottky)
-I _D	Reverse Drain Current
	Continuous (By-pass diode)
	Pulsed [©] (By-pass diode)
V _{GS}	Gate to Source Voltage: Two 15V, 1W back-to-back zeners protected
P_{D}	Power Dissipation
	Each MOSFET 310W
ŀ	(Derate above 25 °C T _C linearly to zero watts at 150 °C T _C)
TJ, TSTG	Operating and Storage Junction Temperature

THERMAL CHARACTERISTICS

R⊖JC	Junction to Case
	MOSFET
	Schottky
	By-pass diode

ELECTRICAL CHARACTERISTICS (Tc = 25°C unless otherwise noted)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
Bydss	Drain to Source Breakdown Voltage	VGS = 0v, ID = 250uA	500			V
I _{DSS+IR}	Zero Gate Drain Current Zero Gate Drain Current (T _C =125 °C)	VDS = 500V, VGS = 0V VDS = 400V, VGS = 0V		_	300 6	μA mA
I _D on	On State Drain Current	VDS > ID ON X RDS ON MAX. VGS = 10V	25	_	_	A
VGS TH	Gate Threshold Voltage	VDS=VGS, ID=1mA	2	_	4	V
RDS ON	Static Drain to Source On Resistance®	VGS=10V, ID=12 5A		_	0.27	ohm
VF	Instantaneous Forward Voltage Drop (By-pass diode) [©]	-ID=25A	_	_	1.6	V
Ciss	Input Capacitance	VGS = 0V, $VDS = 25V$, $F = 1MHz$	1 —	_	2400	pF
td on	Turn-on Delay Time	VDD=250V, ID=25A, VGS=15V, RG=1.8 ohm	T —	_	20	nS
td off	Turn-off Delay Time	VDD=250V, ID=25A, VGS=15V, RG=1.8 ohm	T —		70	nS
tr	Rise Time	VDD=250V, ID=25A, VGS=15V, RG=1.8 ohm	1 —		35	nS
tf	Fall Time	VDD=250V, ID=25A, VGS=15V, RG=1.8 ohm	1 —		45	nS
Qg	Total Gate Charge	VGS = 10V, ID = 25A, VDS = 250V	60	_	95	nC
trr	Reverse Recovery Time (By-pass diode)	IF = 0.5A, $IR = 1A$, $IRR = 0.25A$	T —		50	nS

NOTES: [®] Pulse width limited by maximum junction temperature. [®] 300 uS pulse width at 2 % duty cycle.

Wherever possible, the information supplied is supported by performance and test data. However, no responsibility is assumed by Teledyne Microelectronics for its use Teledyne reserves the right to make changes to this device or device specifications

Contact your local authorized sales representative or the factory direct for any further information on the product